

UNITED STATES PATENT AND TRADEMARK OFFICE  
**CERTIFICATE OF CORRECTION**

PATENT NO. : 6,965,706 B2  
DATED : November 15, 2005  
INVENTOR(S) : Richard Qian et al.

Page 1 of 1

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Title page.

Item [56], **References Cited**, OTHER PUBLICATIONS,  
change "IEEE Transactions of Pattern analysis and machine intelligence, vol. 17, No. 58, May 1995" reference, first occurrence, to -- IEEE Transactions of Pattern analysis and machine intelligence, vol. 17, No. 5, May 1995 --.

Column 5.

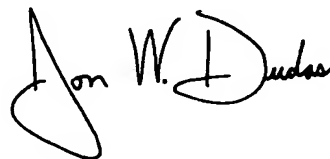
Line 27, change "test area then" to -- test area  $\in$  then --.

Column 6.

Line 63, change " $h_{s,t} = |\{ \epsilon \in I_s \mid t(\epsilon) = f \}|$ " to --  $h_{s,t} = |\{ \epsilon \in I_s \mid t(\epsilon) = t \}|$  --.

Signed and Sealed this

Eighteenth Day of April, 2006



JON W. DUDAS  
*Director of the United States Patent and Trademark Office*